

# IRF7495

HEXFET® Power MOSFET

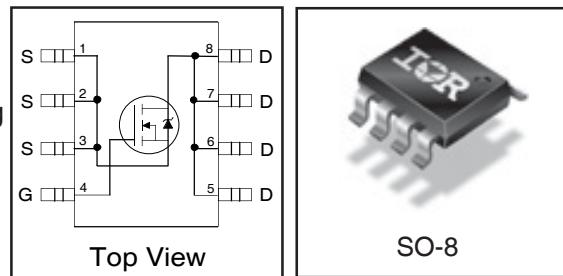
## Applications

- High frequency DC-DC converters

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>I<sub>D</sub></b>
<b>100V</b>	<b>22mΩ@V<sub>GS</sub> = 10V</b>	<b>7.3A</b>

## Benefits

- Low Gate to Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective Coss to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



## Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	7.3	A
I <sub>D</sub> @ T <sub>A</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	4.6	
I <sub>DM</sub>	Pulsed Drain Current ①	58	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/°C
dv/dt	Peak Diode Recovery dv/dt ②	7.3	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 150	
T <sub>STG</sub>	Storage Temperature Range		°C

## Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>0JL</sub>	Junction-to-Drain Lead	—	20	°C/W
R <sub>0JA</sub>	Junction-to-Ambient (PCB Mount) ③	—	50	

Notes ① through ⑥ are on page 8

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**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.10	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	18	22	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 4.4\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{\text{DS}} = 100\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 80\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -20\text{V}$

**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

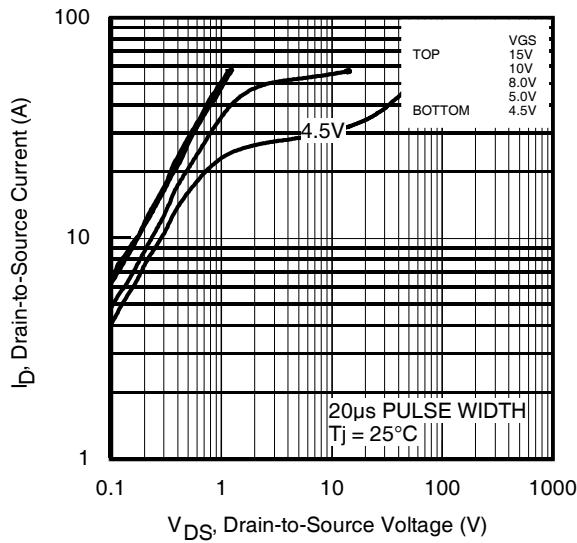
	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{\text{fs}}$	Forward Transconductance	11	—	—	S	$V_{\text{DS}} = 25\text{V}$ , $I_D = 4.4\text{A}$
$Q_g$	Total Gate Charge	—	34	51		$I_D = 4.4\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	6.3	—	nC	$V_{\text{DS}} = 50\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	11.7	—		$V_{\text{GS}} = 10\text{V}$ ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	8.7	—		$V_{\text{DD}} = 50\text{V}$
$t_r$	Rise Time	—	13	—		$I_D = 4.4\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	10	—	ns	$R_G = 6.2\Omega$
$t_f$	Fall Time	—	36	—		$V_{\text{GS}} = 10\text{V}$ ④
$C_{\text{iss}}$	Input Capacitance	—	1530	—		$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	250	—	pF	$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	110	—		$f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	980	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 1.0\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	160	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 80\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	240	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 0\text{V}$ to $80\text{V}$ ⑤

## Avalanche Characteristics

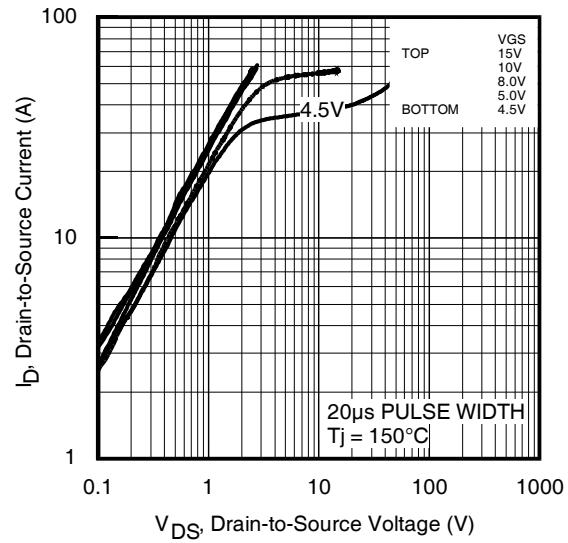
	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	180	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	4.4	A

## Diode Characteristics

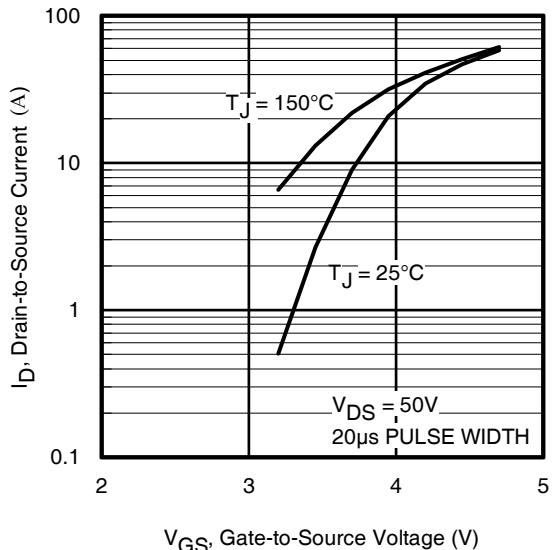
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	2.3		MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	58	A	
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 4.4\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	42	—	ns	$T_J = 25^\circ\text{C}$ , $I_F = 4.4\text{A}$ , $V_{\text{DD}} = 25\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	73	—	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				



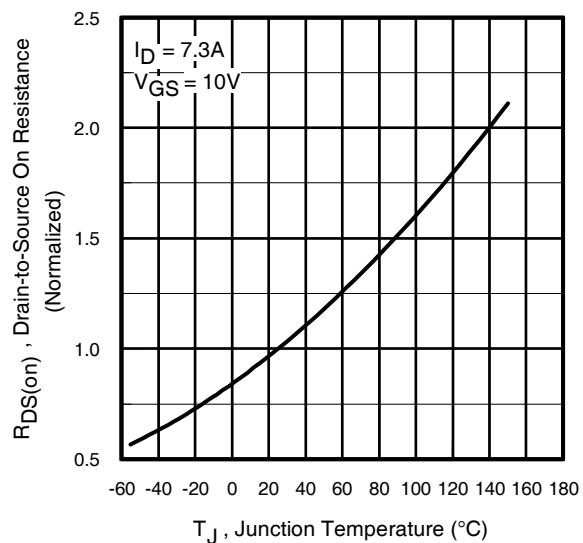
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



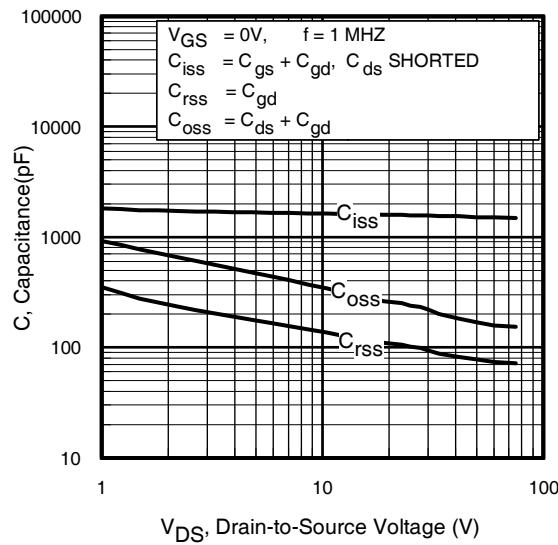
**Fig 3.** Typical Transfer Characteristics



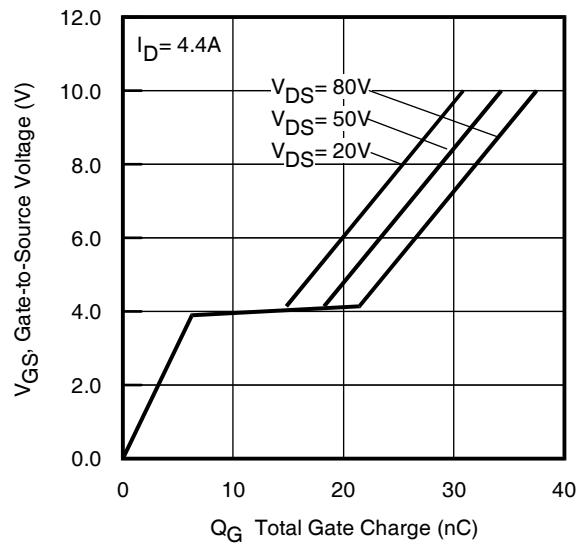
**Fig 4.** Normalized On-Resistance  
vs. Temperature

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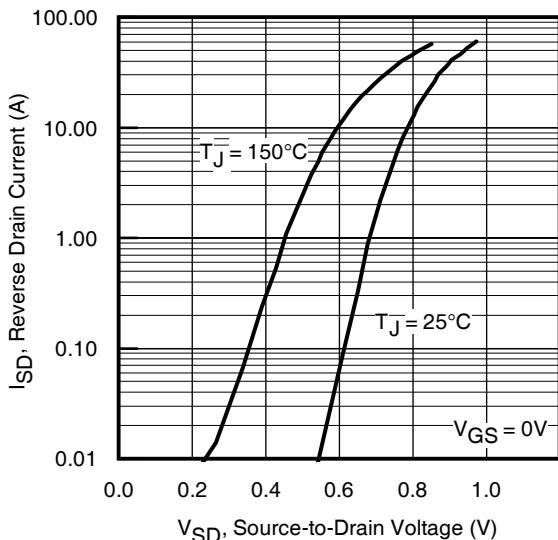
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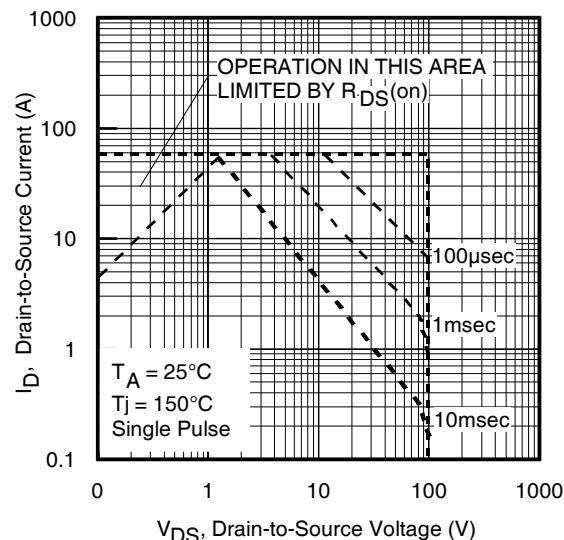
**Fig 5.** Typical Capacitance vs.  
Drain-to-Source Voltage



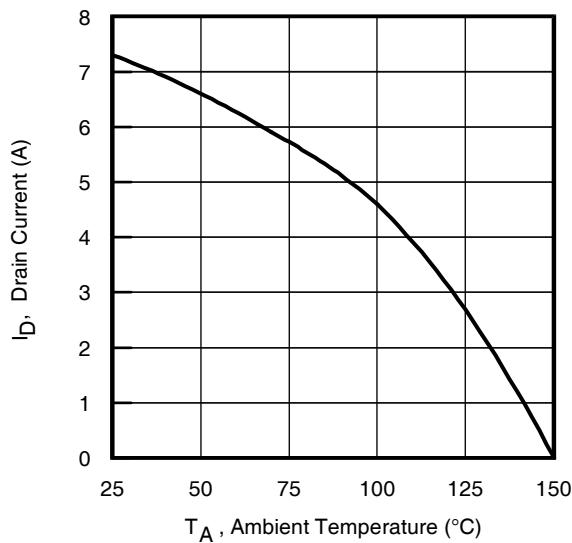
**Fig 6.** Typical Gate Charge vs.  
Gate-to-Source Voltage



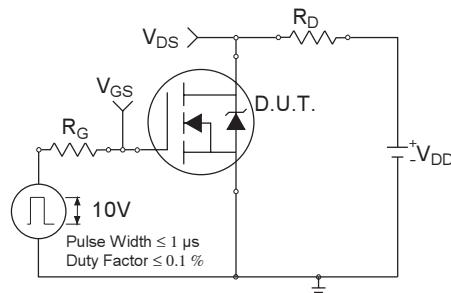
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



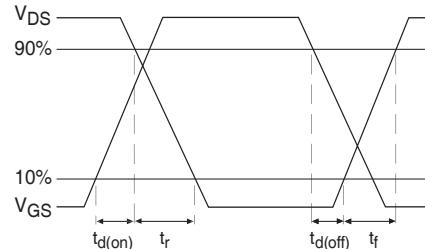
**Fig 8.** Maximum Safe Operating Area



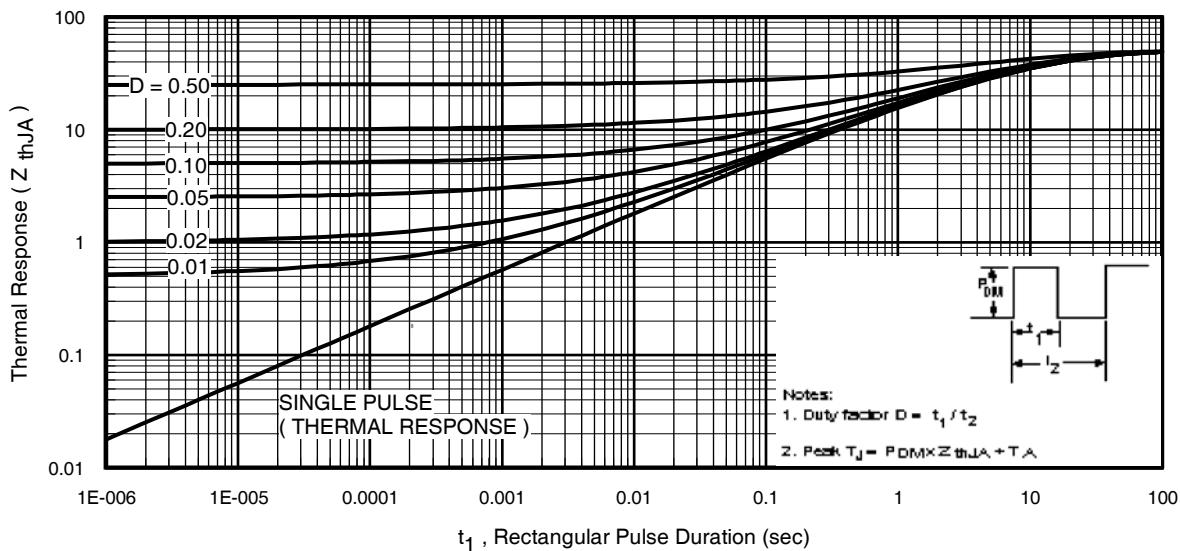
**Fig 9.** Maximum Drain Current vs.  
Ambient Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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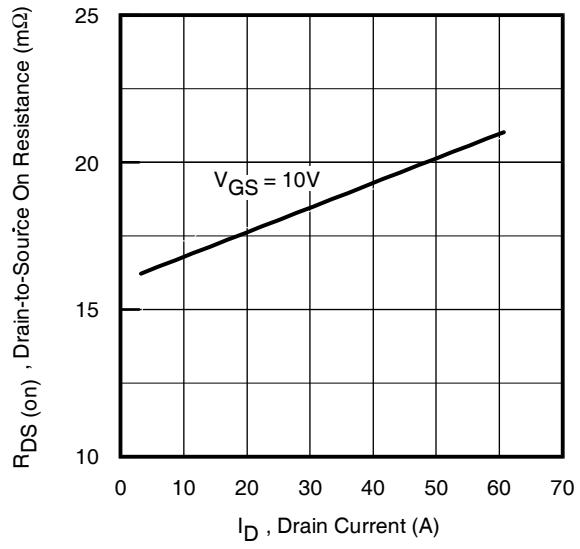


Fig 12. On-Resistance vs. Drain Current

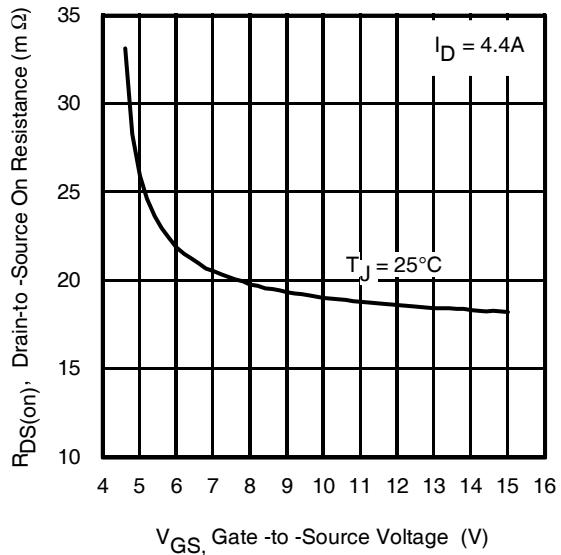


Fig 13. On-Resistance vs. Gate Voltage

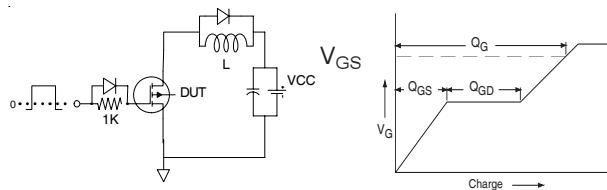


Fig 14a&b. Basic Gate Charge Test Circuit and Waveform

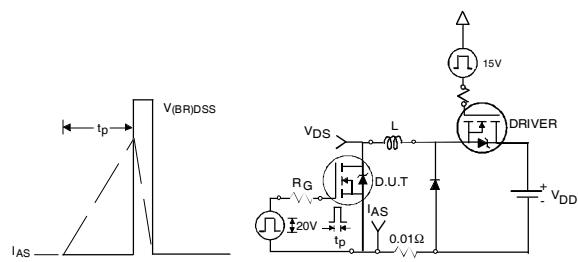


Fig 15a&b. Unclamped Inductive Test circuit and Waveforms

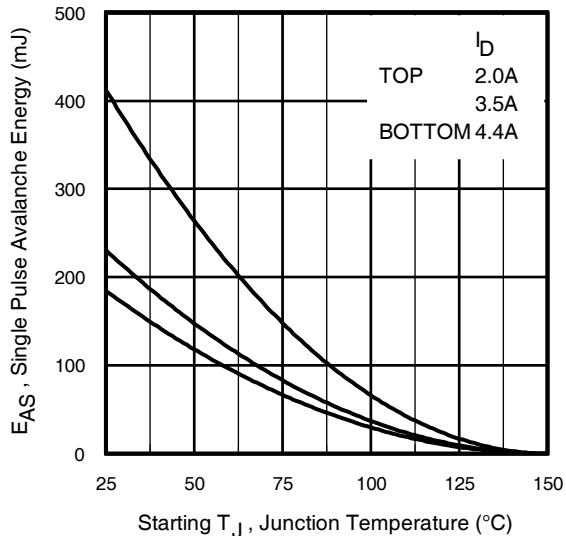


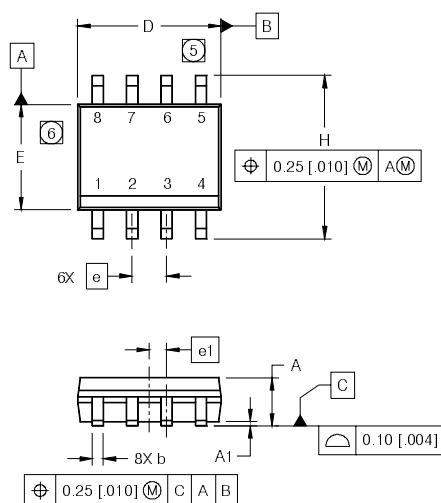
Fig 15c. Maximum Avalanche Energy vs. Drain Current

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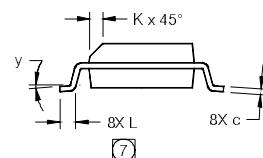
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## SO-8 Package Outline

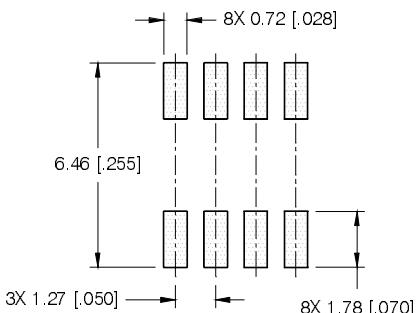
Dimensions are shown in millimeters (inches)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°

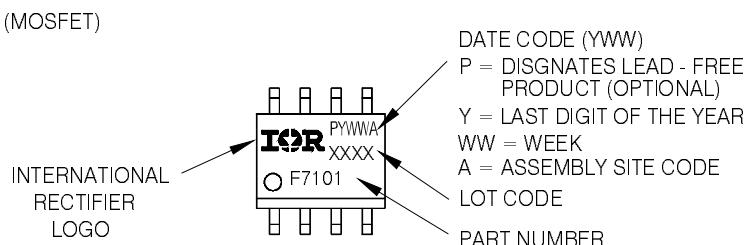


### FOOTPRINT



## SO-8 Part Marking Information

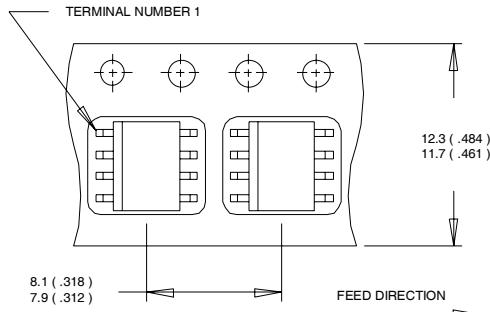
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



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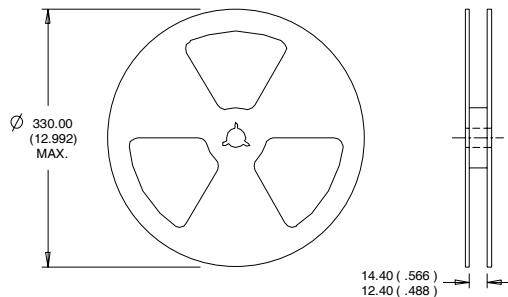
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## SO-8 Tape and Reel



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 19\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 4.4\text{A}$ .
- ③ When mounted on 1 inch square copper board,  $t \leq 10$  sec.
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥  $I_{SD} \leq 5.8\text{A}$ ,  $di/dt \leq 250\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$ .

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

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